## Application/Control No. Applicant(s)/Patent Under Reexamination 10/773,990 BARR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1752 Sin J. Lee **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,869,746 B2 03-2005 Matsumoto et al. 430/270.1 Α В US-6,835,789 B1 12-2004 Kneafsey et al. 526/307.3 US-С US-D US-Ε US-F US-G US-Н

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